Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10561487	DRAYNA ET AL.
Examiner	Art Unit
SANDRA WEGERT	1647

SEARCHED				
Class	Subclass	Date	Examiner	
NONE				

SEARCH NOTES				
Search Notes	Date	Examiner		
STIC: SEQ ID NO: 33. PLEASE SEE SEQUENCE SEARCH RESULTS IN SCORE	7/10/08	SLW		
INVENTORS, PALM, EAST	7/22/08	SLW		
EAST-KEYWORDS, ALL DATABASES	3/12/09	SLW		
NPL-SEE PRINTOUT				
PARENT APPS-REFS CHECKED				
STIC: SEQ ID NO: 33. PLEASE SEE SEQUENCE SEARCH RESULTS IN SCORE. INVENTORS, PALM, EAST. EAST-KEYWORDS, ALL DATABASES. Pubmed-SEE PRINTOUT.				
Patentability Conference. Confer with QAS, 3/12/09	2/26/09	SLW		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examine
	STIC: SEQ ID NO: 33. PLEASE SEE SEQUENCE SEARCH RESULTS IN SCORE. INVENTORS, PALM, EAST. EAST-KEYWORDS, ALL DATABASES. Pubmed- SEE PRINTOUT.	3/12/09	SLW

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